

# N-Channel 200-V (D-S) MOSFET

PRODUCT SUMMARY				
V <sub>(BR)DSS</sub> (V)	$R_{DS(on)}$ (Ω) $I_D$ (A)		Q <sub>g</sub> (Typ.)	
200	0.038 at V <sub>GS</sub> = 15 V	45	57	
	0.043 at V <sub>GS</sub> = 10 V	40	57	

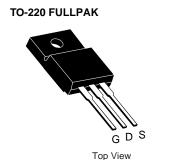
#### **FEATURES**

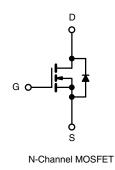
- TrenchFET<sup>®</sup> Power MOSFETS
- 175 °C Junction Temperature
- 100 %  $R_g$  and UIS Tested

#### **APPLICATIONS**

- Power Supply
- Lighting Systems







<b>ABSOLUTE MAXIMUM RATINGS</b>	$T_A = 25 \ ^{\circ}C$ , unless oth	erwise noted		
Parameter	Symbol	Limit	Unit	
Drain-Source Voltage		V <sub>DS</sub>	200	V
Gate-Source Voltage		V <sub>GS</sub>	± 25	V
Continuous Drain Current (T <sub>1</sub> = 175 °C)	T <sub>C</sub> = 25 °C		45	
Continuous Drain Current $(1) = 175$ C)	T <sub>C</sub> = 100 °C	I <sub>D</sub>	26	_
Pulsed Drain Current		I <sub>DM</sub>	150	— A
Single Pulse Avalanche Current	L = 0.1 mH	I <sub>AS</sub>	20	
Single Pulse Avalanche Energy <sup>a</sup>	L = 0.1 mm	E <sub>AS</sub>	20	mJ
Maximum Power Dissipation <sup>a</sup>	T <sub>C</sub> = 25 °C	Р	55 <sup>b</sup>	14/
	T <sub>A</sub> = 25 °C <sup>c</sup>	- P <sub>D</sub> -	3.12	W
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stq</sub>	- 55 to 175	°C

THERMAL RESISTANCE RATINGS				
Parameter	Symbol	Limit	Unit	
Junction-to-Ambient (PCB Mount) <sup>c</sup>	R <sub>thJA</sub>	40	°C/W	
Junction-to-Case (Drain)	R <sub>thJC</sub>	0.75		

Notes:

a. Duty cycle  $\leq$  1 %.

b. See SOA curve for voltage derating.

c. When Mounted on 1" square PCB (FR-4 material).



Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static	-					
Drain-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 V, I_D = 250 \mu A$	200			V
Gate Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_D = 250 \ \mu A$	2.5		4.5	
Gate-Body Leakage	I <sub>GSS</sub>	$V_{DS} = 0 V, V_{GS} = \pm 20 V$			± 100	- nA
		$V_{DS} = 0 V, V_{GS} = \pm 25 V$			± 300	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{DS} = 200 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			1	μΑ
		$V_{DS} = 200 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 100 ^{\circ}\text{C}$			25	
		$V_{DS}$ = 200 V, $V_{GS}$ = 0 V, $T_{J}$ = 150 °C			250	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 10 \text{ V}, \text{ V}_{GS} = 10 \text{ V}$	40			А
Drain-Source On-State Resistance <sup>a</sup>		V <sub>GS</sub> = 10 V, I <sub>D</sub> = 20 A		0.038		- Ω
	Р	V <sub>GS</sub> = 15 V, I <sub>D</sub> = 20 A		0.043		
	R <sub>DS(on)</sub>	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 20 \text{ A}, \text{ T}_{J} = 100 ^{\circ}\text{C}$		0.088		
		V <sub>GS</sub> = 10 V, I <sub>D</sub> = 20 A, T <sub>J</sub> = 150 °C		0.120		
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 20 A	25			S
Dynamic <sup>b</sup>	4				<u> </u>	
Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 25 V, f = 1 MHz		3100		pF
Output Capacitance	C <sub>oss</sub>			300		
Reverse Transfer Capacitance	C <sub>rss</sub>			135		
	0	V <sub>DS</sub> = 100 V, V <sub>GS</sub> = 15 V, I <sub>D</sub> = 50 A		85	127	nC
Total Gate Charge <sup>c</sup>	Qg			57	85	
Gate-Source Charge <sup>c</sup>	Q <sub>gs</sub>	V <sub>DS</sub> = 100 V, V <sub>GS</sub> = 10 V, I <sub>D</sub> = 50 A		14		
Gate-Drain Charge <sup>c</sup>	Q <sub>gd</sub>			20		
Gate Resistance	R <sub>g</sub>	f = 1 MHz		1.2	1.8	Ω
Turn-On Delay Time <sup>c</sup>	t <sub>d(on)</sub>			16	25	ns
Rise Time <sup>c</sup>	t <sub>r</sub>	$V_{DD}$ = 100 V, $R_L$ = 2 $\Omega$		170	260	
Turn-Off Delay Time <sup>c</sup>	t <sub>d(off)</sub>	$I_D \cong 50 \text{ A}, \text{ V}_{\text{GEN}} = 10 \text{ V}, \text{ R}_{\text{g}} = 1 \Omega$		27	42	
Fall Time <sup>c</sup>	t <sub>f</sub>			9	18	
Source-Drain Diode Ratings and Cha	aracteristics 7	Г <sub>С</sub> = 25 °С				
Continuous Current	I <sub>S</sub>				36	_
Pulsed Current	I <sub>SM</sub>				80	A
Forward Voltage <sup>a</sup>	V <sub>SD</sub>	I <sub>F</sub> = 20 A, V <sub>GS</sub> = 0 V		0.86	1.5	V
Reverse Recovery Time	t <sub>rr</sub>			116	175	ns
Peak Reverse Recovery Current	I <sub>RM(REC)</sub>	- I <sub>F</sub> = 40 A, di/dt = 100 A/μs		9	14	А
Reverse Recovery Charge	Q <sub>rr</sub>			0.53	0.8	μC
Reverse Recovery Fall Time	t <sub>a</sub>			84		nS
Reverse Recovery Rise Time	t <sub>b</sub>			32		

Notes:

a. Pulse test; pulse width  $\leq$  300 µs, duty cycle  $\leq$  2 %.

b. Guaranteed by design, not subject to production testing.

c. Independent of operating temperature.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

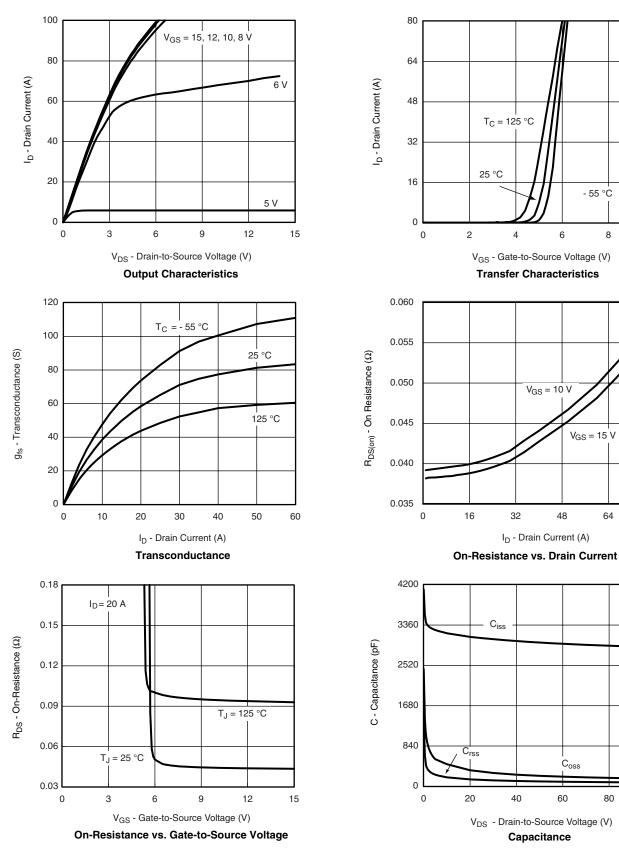


- 55 °C

 $V_{GS} = 15$  V

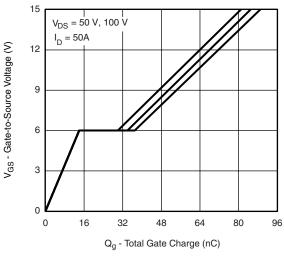
C<sub>oss</sub>

#### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

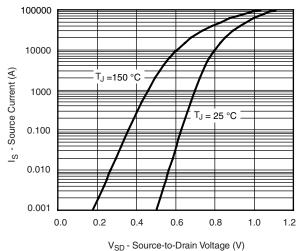


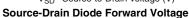


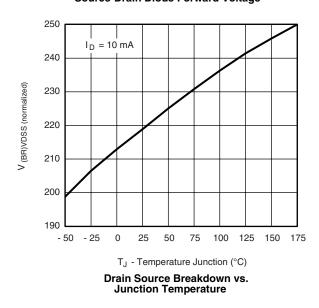
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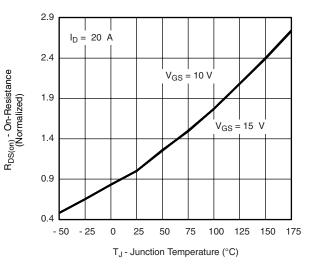




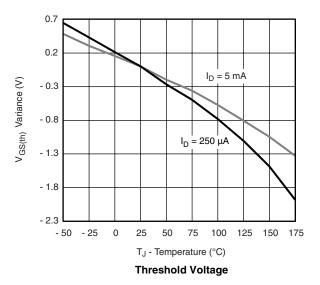


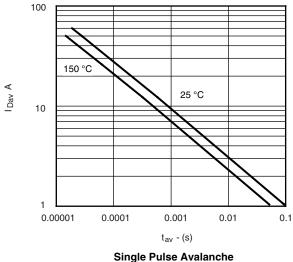






**On-Resistance vs. Junction Temperature** 



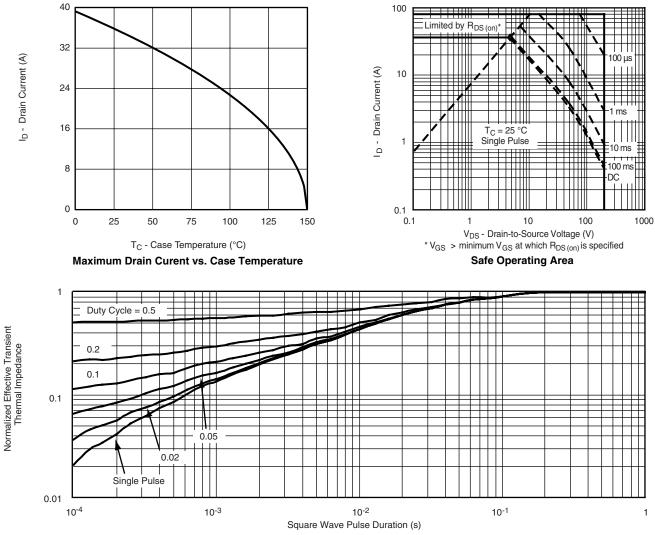


Current Capability vs. Time

### FQPF45N15V2



#### **THERMAL RATINGS**



Normalized Thermal Transient Impedance, Junction-to-Case



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